## Notice of References Cited Application/Control No. 10/518,544 Examiner Thomas P. Noland Applicant(s)/Patent Under Reexamination ROSSKOPF, BERND Page 1 of 1

## U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-4,255,789 A	03-1981	Hartford et al.	701/108
*	В	US-4,455,820 A	06-1984	Buckley et al.	60/773
*	O	US-5,223,207 A	06-1993	Gross et al.	702/116 X
*	D	US-5,798,698 A	08-1998	Politt et al.	340/618
*	Е	US-5,977,913 A	11-1999	Christ, Roger	342/465
*	F	US-2002/0053902 A1	05-2002	Siess, Rainer	324/207.2
*	G	US-2002/0077224 A1	06-2002	Slawinski et al.	482/93
*	Ι	US-2003/0052777 A1	03-2003	Bleier, Thomas E.	340/540
*	I	US-2003/0097230 A1	05-2003	Garabedian, Arminch	702/104
*	J	US-2003/0102966 A1	06-2003	Konchin et al.	340/445
*	K	US-2004/0204890 A1	10-2004	Otterbach et al.	702/116
*	L	US-2006/0055259 A1	03-2006	Hanlon et al.	310/090.5
*	М	US-7,293,400 B2	11-2007	Taware et al.	60/39.27

## FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	DE 3403054 A1	08-1984	Germany	FABER et al.	219/124.34
	0	JP 60070331 A	04-1985	Japan	WATANABE, TAKAO	73/52
	Р	JP 62004948 A	01-1987	Japan	IWATA et al.	477/906
	Q	JP 01081751 A	03-1989	Japan	KANEHIRA, TAMIHIRO	73/1.01
	R	EP 358205 A1	03-1990	European Patent	KROGMANN, UWE	73/178R
	s	JP 2001114089 A	04-2001	Japan	EGUCHI et al.	B60T 8/88
	Т	JP 2002062130 A	02-2002	Japan	OGAWA et al.	G01B 21/20

## **NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	٧	
	W	
	x	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.